

# Guaranteed Reliability

in Demanding  
Automotive  
Environments

PPAP Capable,  
AEC-Q101 Qualified  
Diode Arrays for  
CAN Bus and LIN  
Bus Protection

Is designed to protect automotive  
Controller Area Network (CAN) lines  
and can safely withstand 3A surge  
across very low clamping voltages

Excellent clamping voltages, nominally 36V, and ultra-low dynamic resistance. PPAP capable and AEC-Q101 qualified, able to withstand the harsh environments presented by automotive or industrial.

**Target Application:**

- Drive-by-wire (CAN BUS) lines.
- Engine control modules.
- Anti-lock brakes.
- Air bag and other safety circuits.
- Electronic control units.
- Body control units.
- ADAS control units.
- Power train control units.
- Lightning Control (DALI)



## Automotive Qualified Diode Arrays for CAN Bus and LIN Bus Protection

### Features:

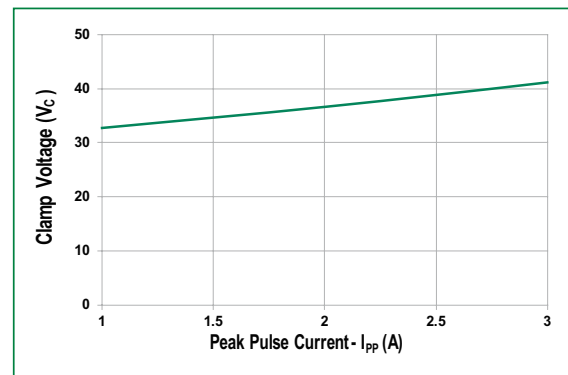
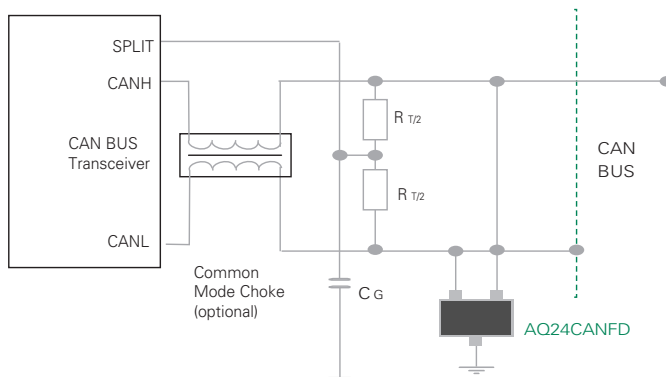
- Low capacitance (11.5 pF typ.)
- Low dynamic resistance ( $0.5\Omega R_{DYN}$ )
- PPAP-capable and AEC-Q101 qualified

### Benefits:

- Helps preserve signal integrity and minimize data loss.
- 10 percent reduction in clamping voltage when compared to similar market solutions for superior clamping performance.
- Clearly defines product flow from wafer creation to back-end processes ensures their provenance

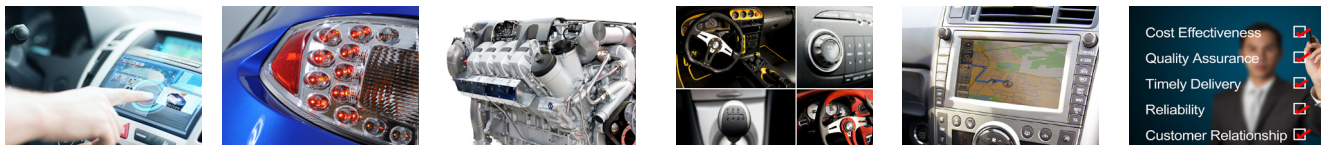
### PPAP Capable

The PPAP-capable device provides enhanced performance verification across a wider temperature range than most commercial products can offer and the clearly defined product flow from wafer creation through packaging, testing, and tape and reel.



### CAN BUS Application Diagram

### Clamping Voltage vs. Ipp



Ordering Number	I <sub>pp</sub> (A)	Reverse Breakdown Voltage (V)	Clamping Voltage (V)	Dynamic Resistance (Ω)	V <sub>ESD</sub> Contact (kV)	Diode Capacitance (pF)	Package	AEC-Q101 Qualified
AQ24CANFD-02HTG	3.0	28 (Typ)	38.7(Typ)	0.5	±21	11.5	SOT23-3	Yes